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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/945,554	08/30/2001	Leonard Forbes	1303.028US1	1837
21186	7590	03/12/2004	EXAMINER	
SCHWEGMAN, LUNDBERG, WOESSNER & KLUTH, P.A. P.O. BOX 2938 MINNEAPOLIS, MN 55402			DICKEY, THOMAS L	
			ART UNIT	PAPER NUMBER
			2826	

DATE MAILED: 03/12/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary

Application No.

09/945,554

Applicant(s)

FORBES, LEONARD

Examiner

Thomas L Dickey

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aw

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 26 January 2004.
- 2a) ☒ This action is FINAL. 2b) ☐ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1,2,4-12,19-27,29-32,34-38,40-44 and 46-50 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) ☒ Claim(s) 7-12,19-27,29-32,34-38,40-44 and 46-49 is/are allowed.
- 6) ☒ Claim(s) 1 and 2 is/are rejected.
- 7) ☒ Claim(s) 4-6 and 50 is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☒ The drawing(s) filed on 30 August 2001 and 26 January 2004 is/are: a) ☒ accepted or b) ☐ objected to by the Examiner.

Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).

Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).

- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some * c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
 2. ☐ Certified copies of the priority documents have been received in Application No. _____.
 3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

* See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- 1) ☒ Notice of References Cited (PTO-892)
- 2) ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948)
- 3) ☒ Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)
Paper No(s)/Mail Date 1/26/04.
- 4) ☐ Interview Summary (PTO-413)
Paper No(s)/Mail Date. _____.
- 5) ☐ Notice of Informal Patent Application (PTO-152)
- 6) ☐ Other: _____.

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DETAILED ACTION

1. The amendment filed on 01/26/04 has been entered.

Drawings

2. The proposed substitute sheets of drawings, filed on 01/26/04 have been approved.

Claim Rejections - 35 USC § 103

3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

Claims 1 and 2 are rejected under 35 U.S.C. 103(a) as being unpatentable over FORBES ET AL. (6,141,248) in view of GARDNER ET AL. (US 6169306 B1).

Forbes et al. discloses a memory cell with a pair of cross coupled inverters 206-308 and 210-312, wherein each inverter includes an NMOS transistor 308,312 and a PMOS transistor 206,210, and wherein at least one of the NMOS transistors 308,312 includes: a first source/drain region 118 and a second source/drain region 122 separated by a channel region 120a in a substrate 120; a floating gate 116 opposing the channel region 120a and separated therefrom by a gate oxide 126; and a control gate 114 opposing the floating gate 116, wherein the control gate 114 is separated from the floating gate 116

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by a intergate insulator 124. With regard to claim 2 Forbes et al. discloses a pair of bitlines coupled to the pair of cross coupled NMOS floating gate transistors at a pair of voltage nodes through a pair of access transistors so that the floating gates are adapted to be programmed with a respective charge state such that the SRAM cell has a definitive asymmetry. Note figures 5B and 8A and column 5 lines 1-60 of Forbes et al. Forbes et al. does not disclose that the intergate insulator is a low tunnel barrier intergate insulator including a metal oxide insulator selected from the group consisting of PbO or Al_2O_3 .

However Gardner et al. discloses a memory cell including at least one NMOS transistor wherein the NMOS transistor includes an intergate insulator 18 comprising any of a fairly large group of transition metal oxide insulators including Al_2O_3 , which is a member of the group consisting of PbO or Al_2O_3 . Note figure 1 and column 3 lines 24-59 of Gardner et al. Note that Gardner et al.'s intergate insulator may be formed by sputtering at low temperatures. Applicant reports that an inherent property of low-temperature sputtered Ta_2O_5 , Perovskite oxide, and Al_2O_3 intergate insulators is that they have low tunnel barriers. Note application, pages 26-30 and 32. Therefore, it would have been obvious to a person having skill in the art to replace the intergate insulator of Forbes et al.'s memory cell with the transition metal oxide Ta_2O_5 , Perovskite oxide BST, or Al_2O_3 low tunnel barrier intergate insulator such as taught by Gardner et al. (note that Gardner et al. does not consider the low tunnel barrier property important enough to mention, it is simply inherent) in order to increase the control gate capacitance without

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requiring that the intergate insulator be thinned to the point where breakdown becomes a hazard. Note that column 2 lines 7-57 of Gardner et al. 6,210,999 teaches the motivation of using Al_2O_3 as an intergate insulator in order to increase the control gate capacitance without requiring that the intergate insulator be thinned to the point where breakdown becomes a hazard.

Allowable Subject Matter

4. Claims 7-12, 19-21, 22-27, 29-32, 34-38, and 40-42 are allowed over the references of record because none of these references disclosed or can be combined to yield the claimed invention such as a memory cell comprising at least a pair of cross coupled NMOS transistors, wherein at least one of the NMOS includes a first source/drain region and a second source/drain region separated by a channel region in a substrate; a floating gate opposing the channel region and separated therefrom by a gate oxide; and a control gate opposing the floating gate, wherein the control gate is separated from the floating gate by a low tunnel barrier intergate insulator, and wherein a metal layer is formed on the floating gate in contact with a low tunnel barrier intergate insulator as recited in claims 7, 11, 22, 26, 31, and 37, or wherein the control gate is the gate having a metal layer formed thereon in contact with a low tunnel barrier intergate insulator as recited in claims 8, 23, 27, 32 or wherein the low tunnel barrier intergate insulator includes a metal layer in contact with one of the floating gate and the control gate, as recited in

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claims 9,19,24, and 29, or the necessary methods of forming the devices of claims 22 and 23, said necessary methods being recited in claims 41 and 42.

5. Claims 43,44, and 46-49 are allowed over the references of record because none of these references disclosed or can be combined to yield the claimed invention such as a method for operating an SRAM cell which includes a pair of cross coupled floating gate transistors, comprising writing to at least one of the cross coupled floating gates of the SRAM cell using channel hot electron injection, wherein the cross coupled floating gate transistors each include: a first source/drain region and a second source/drain region separated by a channel region in a substrate; a floating gate opposing the channel region and separated therefrom by a gate oxide; and a control gate opposing the floating gate, wherein the control gate is separated from the floating gate by a low tunnel barrier intergate insulator; erasing charge from the floating gate by tunneling electrons off of the floating gate and onto the control gate; sensing a logic state of the SRAM cell in a start up mode, and writing to the floating gate by tunneling electrons from the control gate to the floating gate, as recited in claim 43.

6. Claims 4-6 and 50 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

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Response to Arguments

7. Applicant's arguments with respect to claims 1 and 2 have been considered but are moot in view of the new ground(s) of rejection.

Conclusion

THIS ACTION IS MADE FINAL. Applicant is reminded of the extension of time policy Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL.** See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Thomas L Dickey whose telephone number is (571)

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272-1913. The examiner can normally be reached on Monday through Thursday 8 AM to 6 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nathan Flynn can be reached on (703) 308-6601. The fax phone numbers for the organization where this application or proceeding is assigned are 703-872-9306 for all communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 306-3431.

tld
02/2004


Minhloan Tran
Primary Examiner
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